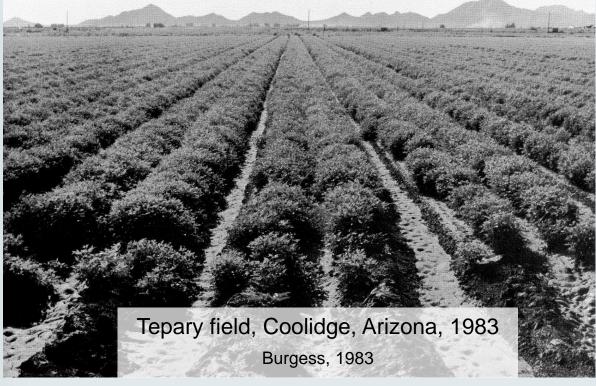
Improved tepary bean holds promise as a climate resilient pulse crop

Tim Porch, USDA-ARS-TARS
Mayaguez, Puerto Rico







Tepary beans likely originated from the Sonoran desert



Probable domestication in Northern Mexico (Garvin and Weeden, 1994; Blair et al., 2012)



Frankie Coburn





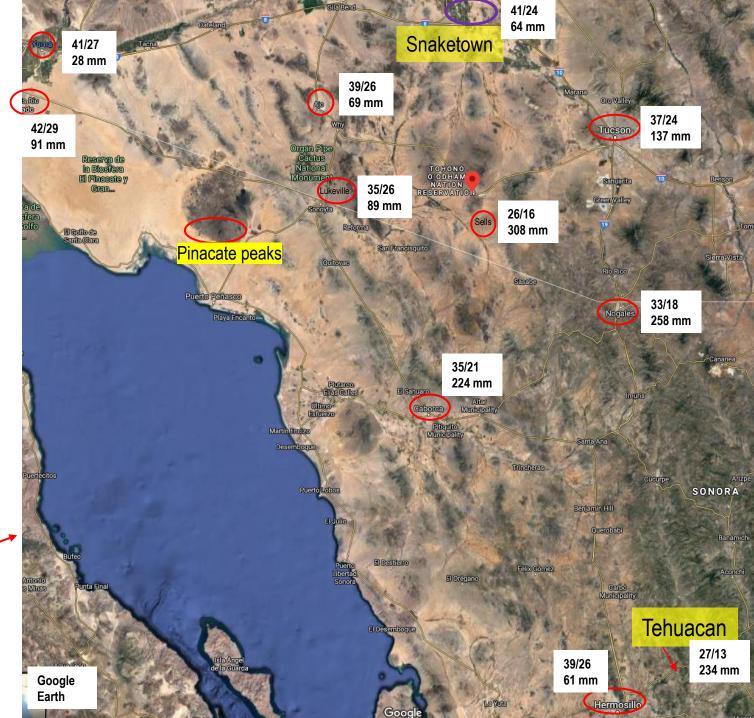
T. Porch (Wilcox, AZ)

Average August temperature (Max/Min, C)

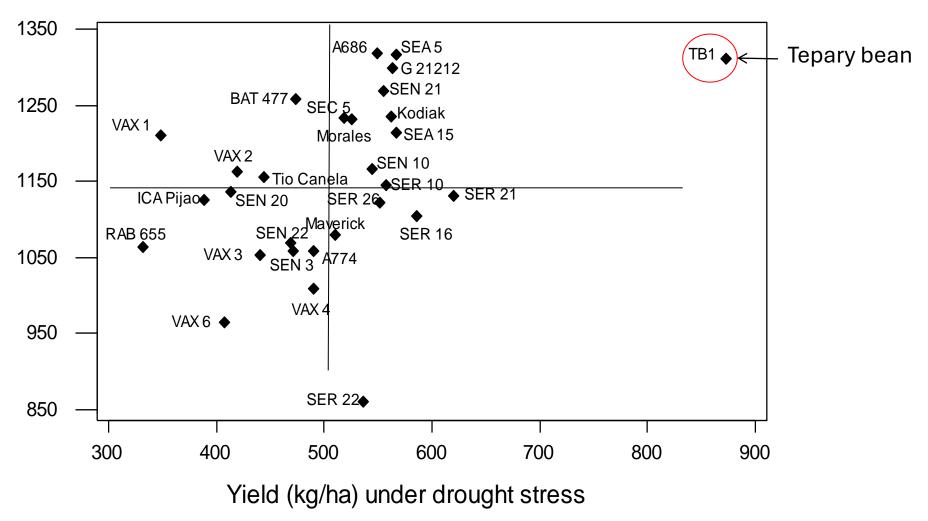
Cumulative Precipitation July-Sept (mm)

-1973 recorded highest temp. of 56.7C (134F) in Sierra Blanca (Felger, 2000)



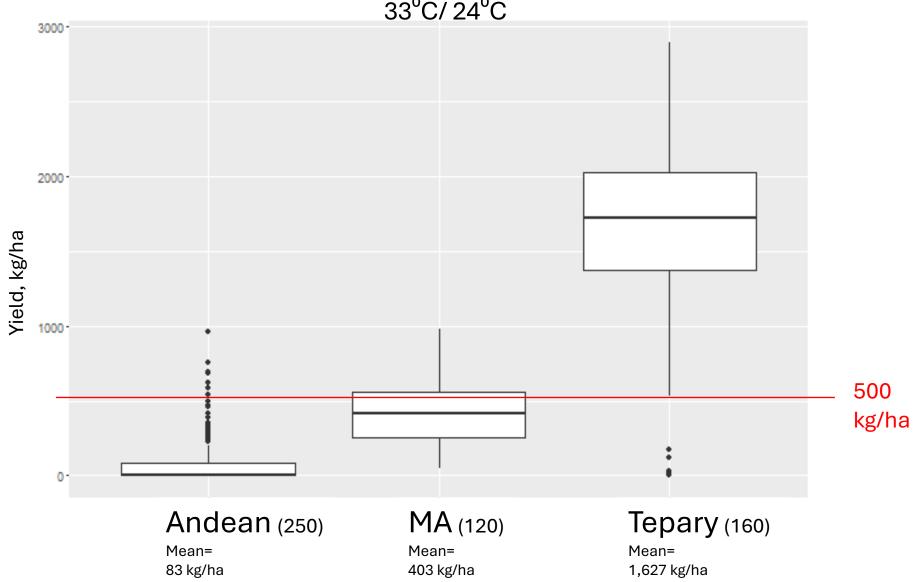


Drought evaluation of elite beans and a tepary bean



Heat tolerance across *Phaseolus* diversity panels

Juana Diaz, Puerto Rico in 2015 33°C/24°C



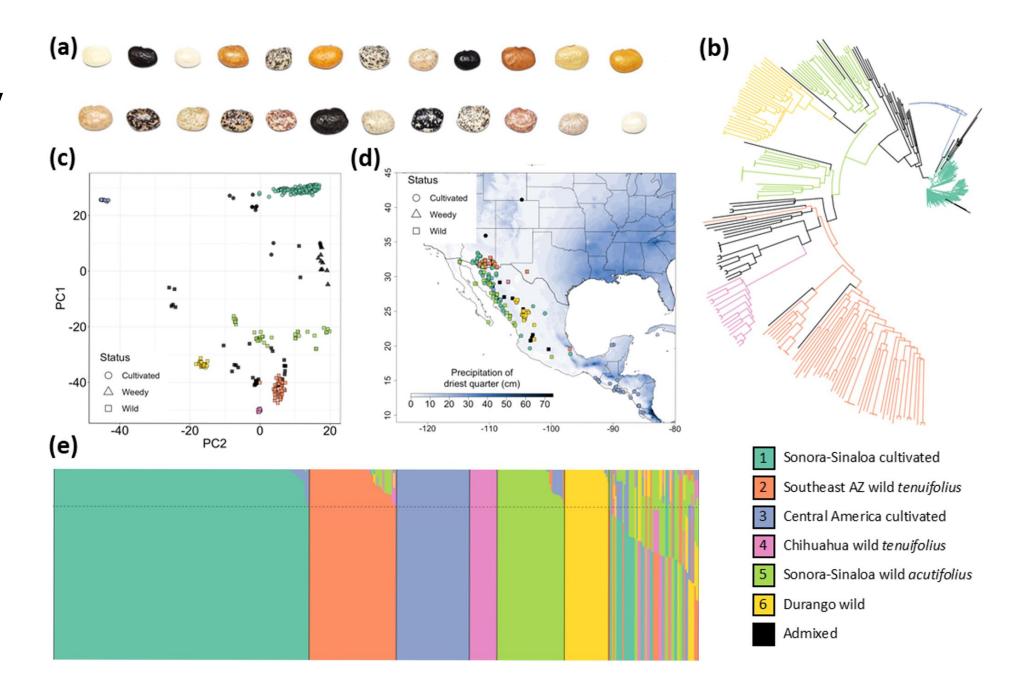
Tepary Diversity Panel

Germplasm

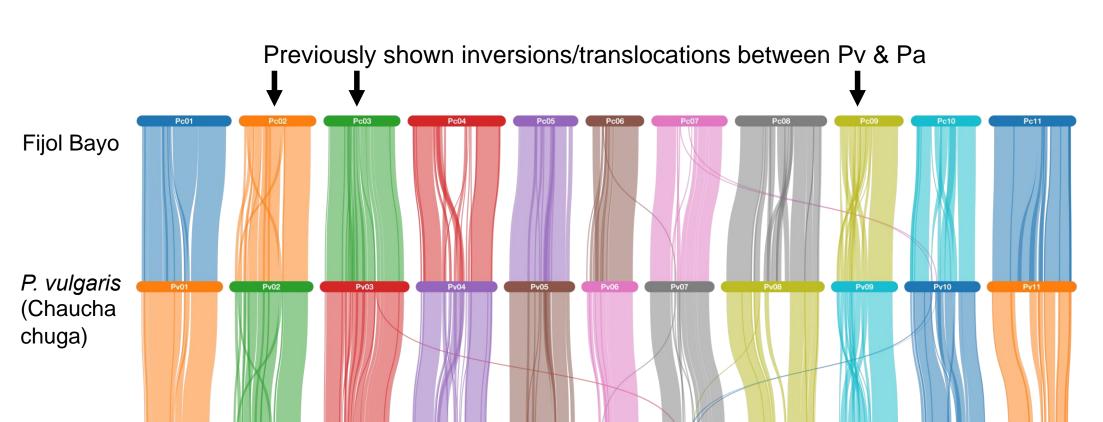
- 422 Accessions
- CIAT (mostly), GRIN, TARS

Genotyping

- ApeKI GBS
- Filtering, and imputation
- LD pruning
- 38,629 SNPs



Extensive Synteny between *Phaseolus* species









W6 15578

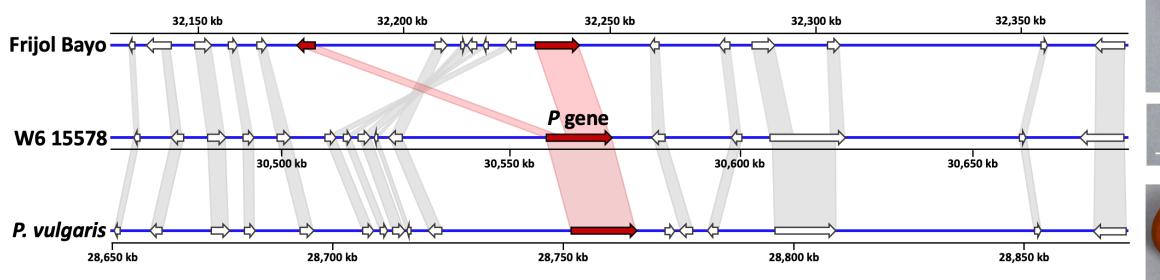
Can we accelerate breeding of both common and tepary bean via leveraging genomic data across Phaseolus species?

- Phacu.001G234100, a P. acutifolius homolog of PvTFL1y, is 99% identical to the P. vulgaris editing.
 - indeterminate allele, providing a target to alter the growth habit of tepary via mutagenesis or gene



Andrew Wiersma

Likewise, white-seed coat color (domestication trait) is associated with an inversion in the P-locus in domesticated tepary bean providing a new allele for the P-locus









Some breeding objectives for crossgenome improvement

From Common Bean

Agronomic Traits:

Habit Pod quality Seed size

Resistance to:

BCMV BCMNV BGYMV Powdery Mildew



Bridging genotypes

From Tepary Bean

Resistance to:

Bacterial blight (CBB)

Rust (immunity)
Bruchid
Leafhopper

Resilience to:

Heat*
Drought*

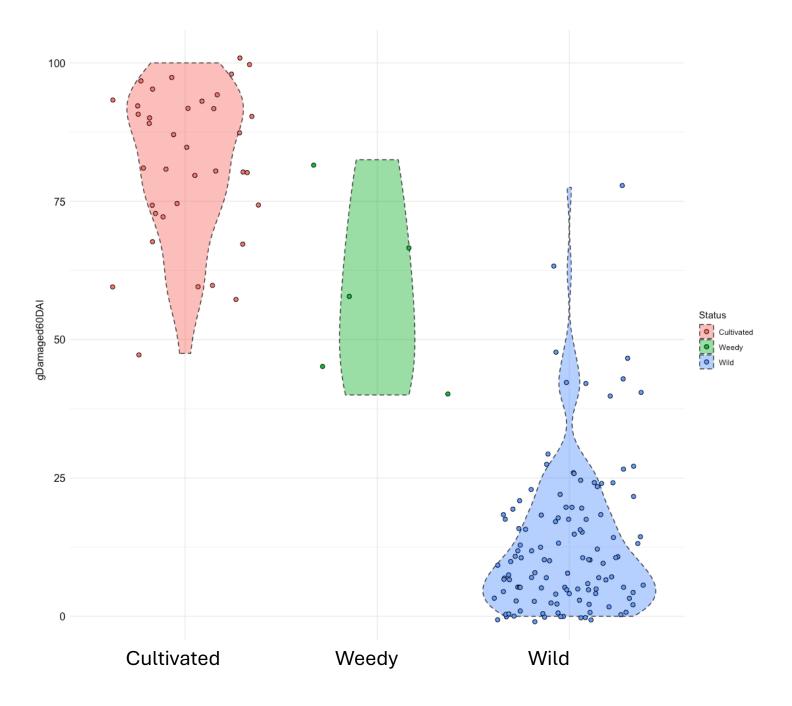
Bruchid damage after 60 days in TDP

Germplasm

- 157 Accessions
- 114 wild, 37 cultivated, 6 weedy



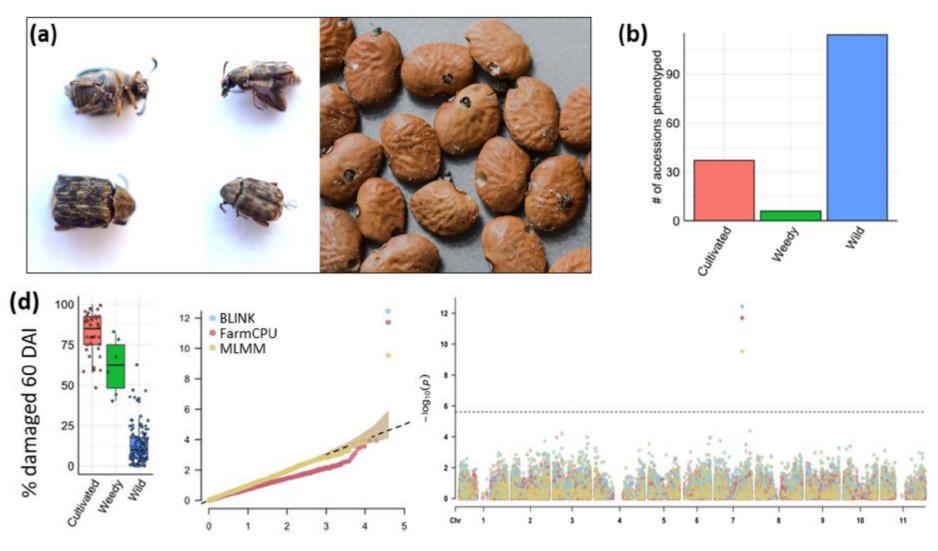




Response of the TDP and breeding lines infested with the common bean weevil, *Acanthoscelides obtectus* (Porch et al., 2022)

TDP#	Accession and origin	Eval. 1 60 d damaged seeds (%)	Eval. 2 60 d damaged seeds (%)	100 seed weight (g)	% loss of initial weight
61	G40078, Wild, Texas	0	0	2.4	0.2
68	G40087, Wild, Durango, Mexico	0	0	7.1	3.0
173	G40196, Wild, Texas	5	5	6.4	0.0
194	G40214, Wild, Arizona	0	0	4.3	8.1
235	G40253A, Wild, Mexico	0	0	3.3	0.2
334	PI 661753, Wild, Unknown	0	0	1.5	0.0
341	PI 640989, Wild, Arizona	0	0	3.1	0.0
372	PI 310803, Cultivated, Nicaragua	60	90	18.7	57.8
318	Bawi, PI 440799, Cultivated, Arizona	90	90	21.1	53.4
312	TARS-Tep 23, Breeding line	100	45	20.6	40.0
NA	TARS-Tep 90, Breeding line	20	12	22.0	46.4
NA	TARS-Tep 93, Breeding line	20	5	16.6	49.0

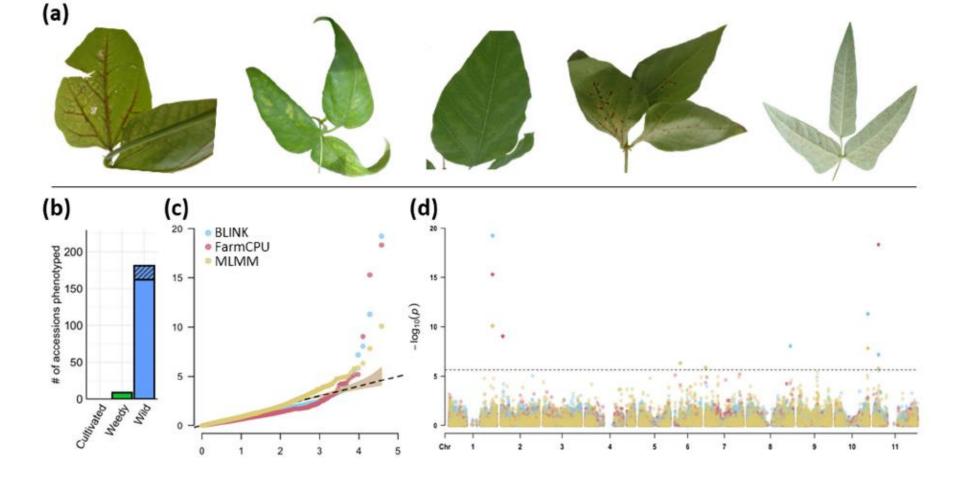
GWAS analysis of bruchid damage at 60 days



BCMNV virus response (NL3 strain)

Evaluated

- 190 Accessions
- Inoculated with NL3
- ELISA readings
- Visual scores

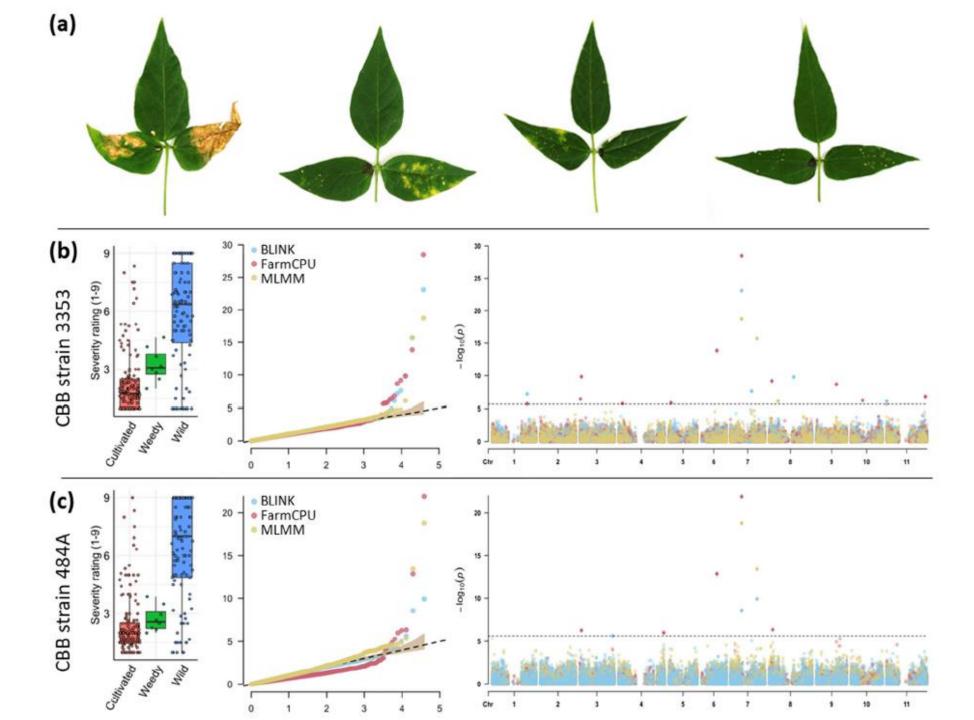


Backcross breeding: Release soon

Common bacterial blight

Germplasm evaluated

- 269 Accessions
- Innoculated with 2 strains: 484A, 3353
- Visual readings



Rust caused by *Uromyces lindemuthianum*

- Highly variable pathogen benefits from cool, humid conditions, long dew periods
- Rust controlled by 13, nine named and four unnamed, resistance genes in common bean, a series: e.g. *Ur-3*, *Ur-4*, *Ur-5*, *Ur-6*, *Ur-11*
- Immunity—not existent in common bean
- Early report showed incomplete dominant resistance in tepary (Miklas and Stavely, 1998)

HORTSCIENCE 33(1):143-145. 1998.

Incomplete Dominance of Rust Resistance in Tepary Bean

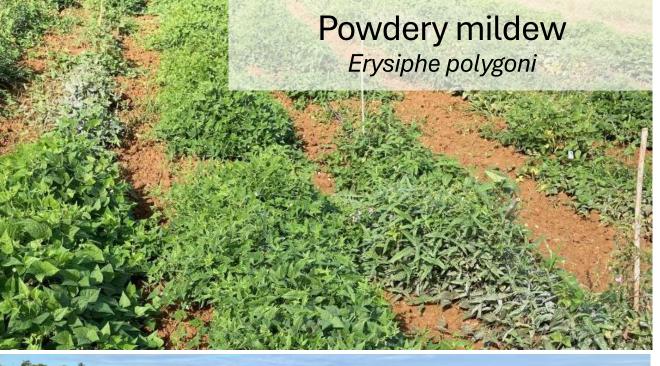
Phillip N. Miklas¹

U.S. Department of Agriculture, Agricultural Research Serr Agriculture and Extension Center, 24106 North Bunn R WA 99350-9687

J. Rennie Stavely²

	Mesoamerio	Mesoamerican races						Andean races	
Line	13-2 (43)	15-3 (47)	22-6 (49)	31-1 (53)	31-22 (67)	22-52 (108)	21-0 (72)	37-1 (84)	
TARS-Tep 23		1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	
TARS-Tep 22	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	1 (R)	
TARS-Tep 29	4 (S)	4 (S)	4 (S)	4 (S)	4, 5 (S)	5 (S)	f2/3 (TP)	2, f2 (S)	
TARS-Tep 32	4 (S)	4, 5 (S)	4, 5 (S)	4 (S)	5, 4 (S)	5, 4 (S)	4 (S)	3 (S)	
G 40001	4, 5, 6 (S)	4, 5 (S)	4, 5 (S)	4, 5 (S)	f2, 3 (TP)	f2, 3 (TP)	f2 (TP)	f2, 3 (TP)	
Pinto UI 114 (check)	4, 5 (S)	5, 6 (S)	5, 6 (S)	4, 5 (S)	4, 5 (S)	4, 5 (S)	5,6 (S)	5, 6 (S)	

(Talo Pastor Corralles, ARS, Beltsville)



Ongoing biotic studies

Pythium root rot *Pythium spp.*







Adjusted means (BLUPs) for TDP accessions showing resistance to Asian bean flower thrips and Empoasca spp. in Isabela, Puerto Rico in 2023

Line	#TDP	Туре	Leaf curl ¹	DTM (days)	Yield (kg/ha)	HSW ² (g)
G40177A2	149	wild	5.3	63.9	998	10.2
21IS-8799-6	NA	improved	5.9	66.8	926	7.5
G40151	121	cultivated	4.7	74.8	663	11.8
TARS-Tep 23	312	improved	6.3	66.6	650	15.7
G40177A1	148	cultivated	5.2	63.8	594	13.3
G40159	128	cultivated	7.7	77.9	586	11.0
G40192	168	wild	5.5	61.8	558	5.2
TARS-Tep 100	437	improved	6.3	66.5	533	15.6
PI 549447	301	cultivated	6.2	68.5	528	11.6
G40016	373	cultivated	7.6	65.1	527	15.5
G40173B	402	wild	5.6	64.2	513	9.0
TARS-Tep 54	419	improved	6.2	66.0	505	10.1
PI 653254	333	silvestre	4.1	59.2	501	5.7
		cultivated				
G40001	1	check	4.6	70.0	117	11.9
		cultivated				
Sacaton white	407	check	6.5	68.2	281	8.7
BLUP			5.1	69.0	207	7.8

¹Leaf curl (1 to 9; 1 resistant and 9 susceptible); ² 100 seed weight.

Breeding objectives

Agronomics

- Yield
- Improved architecture, pod position
- Earliness

Stress tolerance/resistance

- Heat, drought, low soil fertility
- BGYMV, BCMV, CBB, ASB Leafhopper, bruchid, Asian bean flower thrip

Quality

- Larger seed size, rounder shape, solid color
- Reduced cooking time, hard seed

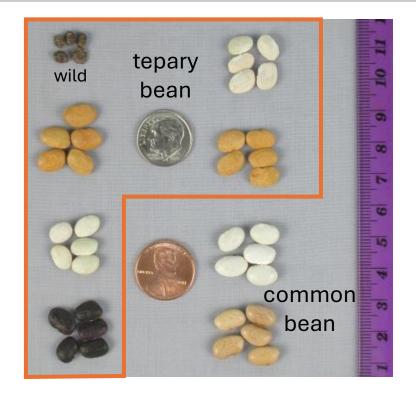
GERMPLASM

Registration of Tepary Germplasm with Multiple-Stress Tolerance, TARS-Tep 22 and TARS-Tep 32

Timothy G. Porch,* James S. Beaver, and Mark A. Brick

ABSTRACT

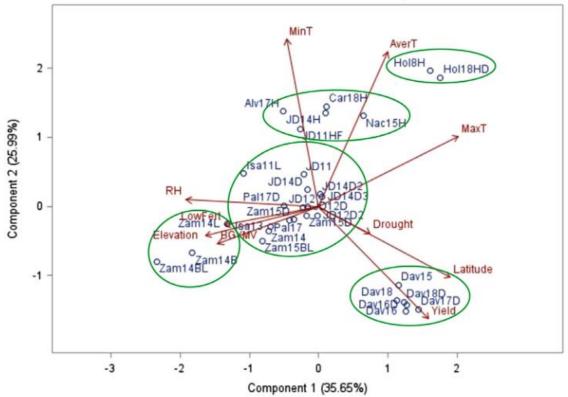
High ambient temperature and drought stress as a result of climate change are increasingly critical factors affecting agriculture, specifically grain legume production. Tepary bean (*Phaseolus acutifolius* A. Gray), a drought- and heat-tolerant species closely related to common bean (*P. vulgaris* L.), has long been employed by Native Americans for production in regions prone to abiotic stress. In addition to abiotic stress, common bacterial blight [caused by *Xanthomonas axonopodis* pv. phaseoli (Smith) Dye] and seed weevils [Acanthoscelides obtectus (Say)] are widespread yield and storage constraints worldwide, respectively. TARS-Tep 22 (Reg. No. GP-288, PI 666350) and TARS-Tep 32 (Reg. No. GP-289, PI 666351) were developed by the USDA-ARS, the University of Puerto Rico Agricultural Experiment Stain, and Colorado State University. The tepary bean germplasms were selected for multiple stress tolerances, including high-temperature and drought stresses and resistance to bacterial blight and seed weevils, and for larger seed size and more erect architecture. TARS-Tep 22 represents the first published release of improved tepary as a result of hybridization and selection, and TARS-Tep 32 is a single plant selection from a landrace (PI 477033) from Arizona. The use of this improved germplasm by farmers in production zones affected by abiotic and/or biotic stress or by breeding programs can potentially increase yields of this newly rediscovered crop.



Germplasm

Release of tepary bean TARS-Tep 23 germplasm with broad abiotic stress tolerance and rust and common bacterial blight resistance

Multidimensional Preference Analysis



TARS-Tep 23



FIGURE 2 Uncooked (left) and cooked (right) seed of TARS-Tep 23. The cooked seed was soaked for 12 h and then cooked for 1 h, both in distilled water. The line represents 1 cm

'USDA Fortuna'

- Improved seed size
- Fast cooking time
- No hard seed
- Resistance to leafhopper, common bacterial blight
- Tolerance to Bean golden yellow mosaic virus



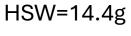
Journal of Plant Registrations

Release of tepary bean cultivar 'USDA Fortuna' with improved disease and insect resistance, seed size, and culinary quality





Improving seed quality in multiple disease resistant white tepary beans





HSW=14 UC Davis—Travis Parker Good performance



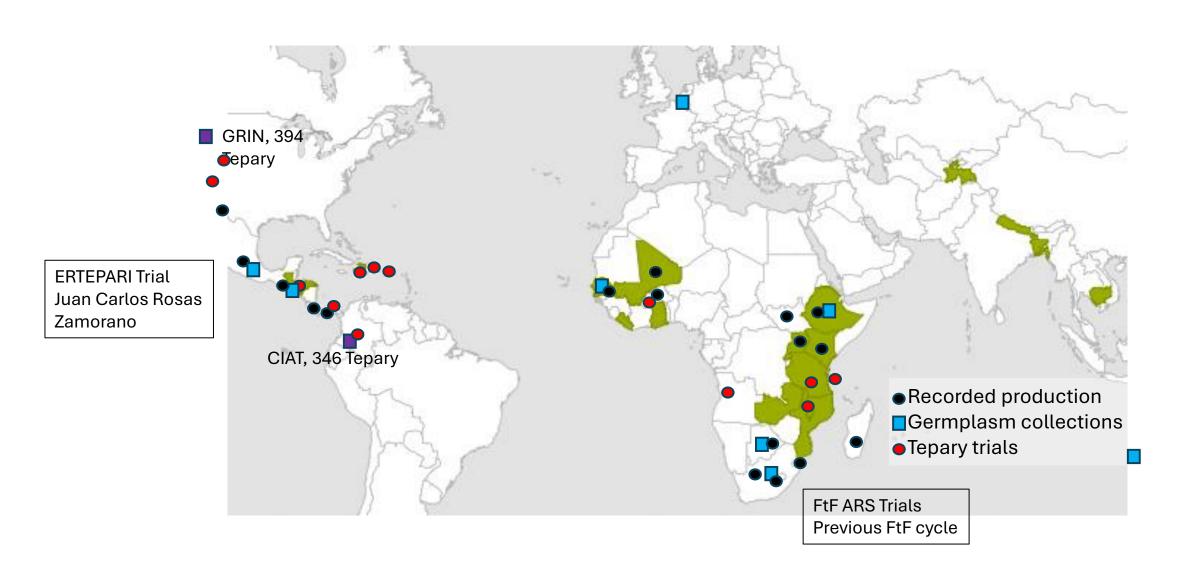
HSW=12.4g Control

HSW=13.6g



HSW=12.3g Control

Tepary dissemination



Conclusions

Tepary, a promising future

- Crop in its own right
- Source of traits for common bean

Reception/adoption of improved tepary bean

- Interest in small seed company in U.S.; Other countries; Granting agencies
- Needed: Cultivars with consumer-driven traits, and improved agronomic performance

Collaborative breeding

- Bulk breeding populations
- Regional nurseries

Tanzania common bean release and description

'Kikatiti'

Pinto bean 2024

(I, bc-3

Rust, Drought, large seed)

Title: Release of 'Kikatiti' a high performing multiple disease resistant pinto cultivar for Tanzania identified from evaluation of the Durango Diversity Panel

Author

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- Porch, Timothy Tim
- Miklas, Phillip Phil

Description of Baetao-Manteiga 41 and 'Yunguilla' superior Andean common beans for Tanzanian production environments

Article · July 2020

DOI: 10.1002/plr2.20072

• (2020): Rust, ALS, moderate CBB resistance



Research Techniques

This web page was developed to provide a review of techniques that are widely accepted and have been successfully used to breed common beans for resistance to biotic and abiotic stress. The goal is to provide an overview of appropriate techniques for breeding common beans for a particular trait and to cite references where researchers, graduate students or technicians can obtain more detailed information. We have also included more general information concerning the evaluation of common beans for the benefit of those who are new to the bean research community. Finally, we identified cultivars and breeding lines that can be used as sources of resistance for particular stresses.

- Angular Leaf Spot
- Anthracnose
- Ashy Stem Blight
- Bacterial Wilt
- BCMV and BCMNV
- Bean Breeding Scales
- Bean Golden Yellow Mosaic
- Bean Processing
- Bean Root Rots
- Brazilian Beans
- Bruchid Insect Breeding (English)
- Bruchid Insect Breeding (Spanish)
- Climbing Bean Production Manual Spanish
- Color Scales
- Common Bacterial Blight
- Coop Dry Bean Nursery 2010
- Drought Stress
- Fusarium Wilt
- Halo Blight
- Duct
- Snap Bean Traits for Processing
- Web Blight

Bean Improvement Cooperative

www.bic.uprm.edu

- Worldwide research community
- Annual Report with membership
- 2-year membership is \$40
- Conferences every 2 years
- 2025, Beginning of November
 - -Lincoln Nebraska

Collaborators USDA-ARS

- TARS Bean Team
- Karen Cichy, Talo Pastor-Corrales
 University of Puerto Rico
- James Beaver, Consuelo Estevez
 University of Georgia—Robin Buell
 Michigan State University
- Nolan Boronowski, Andrew Wiersma, Ali Soltani, David Lowry

Zamorano University—Juan Carlos Rosas North Dakota State U.—Phil McClean, S. Mafi Moghaddam University of California, Davis

- Paul Gepts, Travis ParkerCIAT Bean ProgramFtF Grain Legume Collaborators
- Deidre Fourie, Susan Nchimbi, Emmanuel Prophete,
 Graciela Godoy











